

Search Notes

Application/Control No.

10/760,671

Examiner

James J. Debrow

Applicant(s)/Patent under
Reexamination

LIU ET AL.

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	500	6/29/2006	JD
715	706	6/29/2006	JD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventor search	6/29/2006	JD
searched related cases	6/29/2006	JD
text search in EAST(see search notes)	6/29/2006	JD
text search in STIC database(see search notes)	7/13/2006	JD